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REVISION HISTORY

8/2016—Rev. C to Rev. D

Changes to Analog Inputs Parameter and Digital Inputs Parameter, Table 3.....	7
Updated Outline Dimensions	17

3/2016—Rev. B to Rev. C

Changes to Figure 5 and Figure 6	9
Updated Outline Dimensions	17
Changes to Ordering Guide	17

2/2009—Rev. A to Rev. B

Change to I_{DD} Parameter, Table 1	4
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Updated Outline Dimensions	16

8/2006—Rev. 0 to Rev. A

Updated Format.....	\Universal
Changes to Table 1.....	13
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Changes to Figure 11.....	110
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1/2006—Revision 0: Initial Version

SPECIFICATIONS

DUAL SUPPLY

$V_{DD} = +15\text{ V} \pm 10\%$, $V_{SS} = -15\text{ V} \pm 10\%$, GND = 0 V, unless otherwise noted.

Table 1.

Parameter	Y Version ¹			Unit	Test Conditions/Comments
	+25°C	−40°C to +85°C	−40°C to +125°C		
ANALOG SWITCH					
Analog Signal Range			V _{SS} to V _{DD}	V	V _S = ±10 V, I _S = −1 mA; see Figure 24 V _{DD} = +13.5 V, V _{SS} = −13.5 V V _S = ±10 V, I _S = −1 mA
On Resistance (R _{ON})	120			Ω typ	
	190	230	260	Ω max	
On Resistance Match Between Channels (ΔR _{ON})	3.5			Ω typ	
	6	10	12	Ω max	V _S = −5 V, 0 V, +5 V; I _S = −1 mA
On Resistance Flatness (R _{FLAT (ON)})	20			Ω typ	
	60	72	79	Ω max	
LEAKAGE CURRENTS					
Source Off Leakage I _S (Off)	±0.02			nA typ	V _{DD} = +16.5 V, V _{SS} = −16.5 V V _D = ±10 V, V _S = −10 V; see Figure 25
	±0.1	±0.6	±1	nA max	
Drain Off Leakage I _D (Off)	±0.02			nA typ	V _S = 1 V/10 V, V _D = 10 V/1 V; see Figure 25
	±0.1	±0.6	±1	nA max	
Channel On Leakage I _D , I _S (On)	±0.02			nA typ	V _S = V _D = ±10 V; see Figure 26
	±0.2	±0.6	±1	nA max	
DIGITAL INPUTS					
Input High Voltage, V _{INH}			2.0	V min	V _{IN} = V _{INL} or V _{INH}
Input Low Voltage, V _{INL}			0.8	V max	
Input Current					
I _{INL} or I _{INH}	±0.005		±0.1	μA typ	
				μA max	
Digital Input Capacitance, C _{IN}	3			pF typ	
DYNAMIC CHARACTERISTICS ²					
t _{TRANSITION}	110			ns typ	R _L = 300 Ω, C _L = 35 pF V _S = 10 V; see Figure 27
	130	150	170	ns max	
t _{BBM}	25			ns typ	R _L = 300 Ω, C _L = 35 pF V _{S1} = V _{S2} = +10 V; see Figure 28
			10	ns min	
t _{ON} ($\overline{\text{EN}}$)	120			ns typ	R _L = 300 Ω, C _L = 35 pF V _S = 10 V; see Figure 29
	140	170	195	ns max	
t _{OFF} ($\overline{\text{EN}}$)	40			ns typ	R _L = 300 Ω, C _L = 35 pF V _S = 10 V; see Figure 29
	45	55	60	ns max	
Charge Injection	0.5			pC typ	V _S = 0 V, R _S = 0 Ω, C _L = 1 nF; see Figure 30
Off Isolation	−80			dB typ	R _L = 50 Ω, C _L = 5 pF, f = 1 MHz; see Figure 31
Channel-to-Channel Crosstalk	−85			dB typ	R _L = 50 Ω, C _L = 5 pF, f = 1 MHz; see Figure 33
Total Harmonic Distortion, THD + N	0.14			% typ	R _L = 10 kΩ, 5 V rms, f = 20 Hz to 20 kHz; see Figure 34
−3 dB Bandwidth	900			MHz typ	R _L = 50 Ω, C _L = 5 pF; see Figure 32
C _S (Off)	1.5			pF typ	
	1.7			pF max	f = 1 MHz; V _S = 0 V
C _D (Off)	1.6			pF typ	f = 1 MHz; V _S = 0 V
	1.8			pF max	f = 1 MHz; V _S = 0 V

Parameter	Y Version ¹			Unit	Test Conditions/Comments
	+25°C	–40°C to +85°C	–40°C to +125°C		
C _D , C _S (On)	3.5 4			pF typ pF max	f = 1 MHz; V _S = 0 V f = 1 MHz; V _S = 0 V
POWER REQUIREMENTS					V _{DD} = +16.5 V, V _{SS} = –16.5 V
I _{DD}	0.002		1.0	μA typ μA max	Digital inputs = 0 V or V _{DD}
I _{DD}	260		475	μA typ μA max	Digital inputs = 5 V
I _{SS}	0.002		1.0	μA typ μA max	Digital inputs = 0 V or V _{DD}
I _{SS}	0.002		1.0	μA typ μA max	Digital inputs = 5 V
V _{DD} /V _{SS}			±5/±16.5	V min/max	GND = 0 V

¹ Temperature range for the Y version: –40°C to +125°C.

² Guaranteed by design, not subject to production test.

SINGLE SUPPLY

$V_{DD} = 12\text{ V} \pm 10\%$, $V_{SS} = 0\text{ V}$, $GND = 0\text{ V}$, unless otherwise noted.

Table 2.

Parameter	Y Version ¹			Unit	Test Conditions/Comments
	+25°C	−40°C to +85°C	−40°C to +125°C		
ANALOG SWITCH					
Analog Signal Range			0 to V _{DD}	V	
On Resistance (R _{ON})	300			Ω typ	V _S = 0 V to 10 V, I _S = −1 mA; see Figure 24
On Resistance Match Between Channels (ΔR _{ON})	475	567	625	Ω max	V _{DD} = 10.8 V, V _{SS} = 0 V
	5			Ω typ	V _S = 0 V to 10 V, I _S = −1 mA
On Resistance Flatness (R _{FLAT (ON)})	16	26	27	Ω max	
	60			Ω typ	V _S = 3 V, 6 V, 9 V, I _S = −1 mA
LEAKAGE CURRENTS					
Source Off Leakage I _S (Off)	±0.02			nA typ	V _{DD} = 13.2 V V _S = 1 V/10 V, V _D = 10 V/1 V; see Figure 25
Drain Off Leakage I _D (Off)	±0.1	±0.6	±1	nA max	
	±0.02			nA typ	V _S = 1 V/10 V, V _D = 10 V/1 V; see Figure 25
Channel On Leakage I _D , I _S (On)	±0.1	±0.6	±1	nA max	
	±0.02			nA typ	V _S = V _D = 1 V or 10 V, see Figure 26
	±0.2	±0.6	±1	nA max	
DIGITAL INPUTS					
Input High Voltage, V _{INH}			2.0	V min	
Input Low Voltage, V _{INL}			0.8	V max	
Input Current, I _{INL} or I _{INH}	±0.001			μA typ	
			±0.1	μA max	V _{IN} = V _{INL} or V _{INH}
Digital Input Capacitance, C _{IN}	2			pF typ	
DYNAMIC CHARACTERISTICS ²					
t _{TRANSITION}	135			ns typ	R _L = 300 Ω, C _L = 35 pF
	170	200	230		V _S = 8 V; see Figure 27
t _{BBM}	45			ns typ	R _L = 300 Ω, C _L = 35 pF
			10	ns min	V _{S1} = V _{S2} = 8 V; see Figure 28
t _{ON} ($\overline{\text{EN}}$)	150			ns typ	R _L = 300 Ω, C _L = 35 pF
	195	230	265		V _S = 8 V; see Figure 29
t _{OFF} ($\overline{\text{EN}}$)	45			ns typ	R _L = 300 Ω, C _L = 35 pF
	60	70	75		V _S = 8 V; see Figure 29
Charge Injection	−0.3			pC typ	V _S = 6 V, R _S = 0 Ω, C _L = 1 nF; see Figure 30
Off Isolation	−80			dB typ	R _L = 50 Ω, C _L = 5 pF, f = 1 MHz; see Figure 31
Channel-to-Channel Crosstalk	−85			dB typ	R _L = 50 Ω, C _L = 5 pF, f = 1 MHz; see Figure 33
−3 dB Bandwidth	600			MHz typ	R _L = 50 Ω, C _L = 5 pF; see Figure 32
C _S (Off)	1.5			pF typ	f = 1 MHz; V _S = 6 V
	1.7			pF max	f = 1 MHz; V _S = 6 V
C _D (Off)	2			pF typ	f = 1 MHz; V _S = 6 V
	2.2			pF max	f = 1 MHz; V _S = 6 V
C _D , C _S (On)	4			pF typ	f = 1 MHz; V _S = 6 V
	4.5			pF max	f = 1 MHz; V _S = 6 V

Parameter	Y Version ¹			Unit	Test Conditions/Comments
	+25°C	–40°C to +85°C	–40°C to +125°C		
POWER REQUIREMENTS					
I_{DD}	0.002		1.0	$\mu\text{A typ}$	$V_{DD} = 13.2\text{ V}$ Digital inputs = 0 V or V_{DD}
I_{DD}	260		475	$\mu\text{A max}$	Digital inputs = 5 V
V_{DD}			5/16.5	$\mu\text{A typ}$ $\mu\text{A max}$ V min/max	$V_{SS} = 0\text{ V}$, GND = 0 V

¹ Temperature range for the Y version: –40°C to +125°C² Guaranteed by design, not subject to production test.

ABSOLUTE MAXIMUM RATINGS

$T_A = 25^\circ\text{C}$, unless otherwise noted.

Table 3.

Parameter	Rating
V_{DD} to V_{SS}	35 V
V_{DD} to GND	$-0.3\text{ V to }+25\text{ V}$
V_{SS} to GND	$+0.3\text{ V to }-25\text{ V}$
Analog Inputs ¹	$V_{SS} - 0.3\text{ V to }V_{DD} + 0.3\text{ V}$ or 30 mA (whichever occurs first)
Digital Inputs	GND $- 0.3\text{ V to }V_{DD} + 0.3\text{ V}$ or 30 mA (whichever occurs first)
Continuous Current, S or D	24 mA
Peak Current, S or D (Pulsed at 1 ms, 10% Duty Cycle Maximum)	100 mA
Operating Temperature Range	
Automotive Temperature Range (Y Version)	$-40^\circ\text{C to }+125^\circ\text{C}$
Storage Temperature Range	$-65^\circ\text{C to }+150^\circ\text{C}$
Junction Temperature	150°C
TSSOP, θ_{JA} , Thermal Impedance	112°C/W
LFCSP, θ_{JA} , Thermal Impedance	30.4°C/W
Reflow Soldering Peak Temperature, Pb-Free	260°C

¹ Overvoltages at A, $\overline{\text{EN}}$, S, or D are clamped by internal diodes. Current must be limited to the maximum ratings given.

Stresses at or above those listed under Absolute Maximum Ratings may cause permanent damage to the product. This is a stress rating only; functional operation of the product at these or any other conditions above those indicated in the operational section of this specification is not implied. Operation beyond the maximum operating conditions for extended periods may affect product reliability.

Only one absolute maximum rating is applied at any one time.

ESD CAUTION



ESD (electrostatic discharge) sensitive device.

Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

PIN CONFIGURATIONS AND FUNCTION DESCRIPTIONS

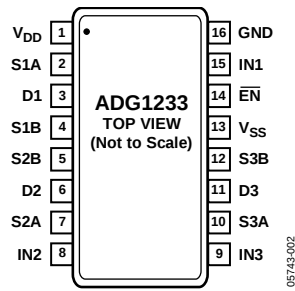


Figure 3. 16-Lead TSSOP Pin Configuration

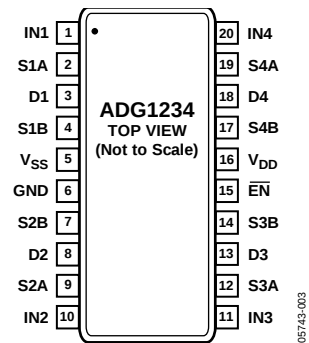
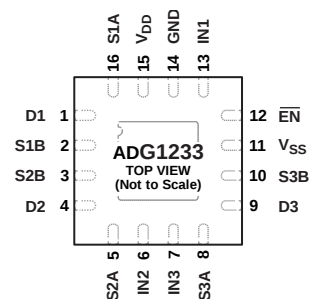


Figure 4. 20-Lead TSSOP Pin Configuration

Table 4. 16-Lead TSSOP/20-Lead TSSOP Pin Configurations

Pin No. ADG1233 16-Lead TSSOP	Pin No. ADG1234 20-Lead TSSOP	Mnemonic
1	16	V _{DD}
2	2	S1A
3	3	D1
4	4	S1B
5	7	S2B
6	8	D2
7	9	S2A
8	10	IN2
9	11	IN3
10	12	S3A
11	13	D3
12	14	S3B
13	5	V _{SS}
14	15	EN
15	1	IN1
16	6	GND
Not applicable	17	S4B
Not applicable	18	D4
Not applicable	19	S4A
Not applicable	20	IN4

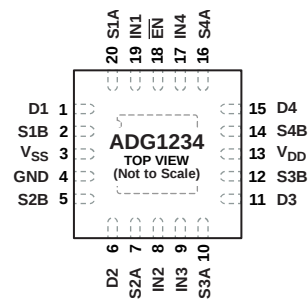


NOTES

1. NC = NO CONNECT. DO NOT CONNECT TO THIS PIN.
2. THE EXPOSED PAD MUST BE TIED TO SUBSTRATE, V_{SS} .

05743-004

Figure 5. 16-Lead, 4 mm × 4 mm LFCSP Pin Configuration, Exposed Pad Tied to Substrate, V_{SS}



NOTES

1. THE EXPOSED PAD MUST BE TIED TO SUBSTRATE, V_{SS} .

05743-005

Figure 6. 20-Lead, 4 mm × 4 mm LFCSP Pin Configuration, Exposed Pad Tied to Substrate, V_{SS}

Table 5. 16-Lead LFCSP/20-Lead LFCSP Pin Configurations

Pin No. ADG1233 16-Lead LFCSP	Pin No. ADG1234 20-Lead LFCSP	Mnemonic
1	1	D1
2	2	S1B
3	5	S2B
4	6	D2
5	7	S2A
6	8	IN2
7	9	IN3
8	10	S3A
9	11	D3
10	12	S3B
11	3	V_{SS}
12	18	EN
13	19	IN1
14	4	GND
15	13	V_{DD}
16	20	S1A
Not applicable	14	S4B
Not applicable	15	D4
Not applicable	16	S4A
Not applicable	17	IN4

Table 6. **ADG1233/ADG1234** Truth Table

EN	INx	Switch xA	Switch xB
1	X	Off	Off
0	0	Off	On
0	1	On	Off

TERMINOLOGY

V_{DD}

Most positive supply potential.

V_{SS}

Most negative power supply potential in dual supplies. In single-supply applications, it can be connected to ground.

GND

Ground (0 V) reference.

R_{ON}

Ohmic resistance between D and S.

ΔR_{ON}

Difference between the R_{ON} of any two channels.

I_S (Off)

Source leakage current when switch is off.

I_D (Off)

Drain leakage current when switch is off.

I_D, I_S (On)

Channel leakage current when switch is on.

V_D, V_S

Analog voltage on Terminal D, Terminal S.

C_S (Off)

Channel input capacitance for off condition.

C_D (Off)

Channel output capacitance for off condition.

C_D, C_S (On)

On switch capacitance.

C_{IN}

Digital input capacitance.

t_{ON} ($\overline{\text{EN}}$)

Delay time between the 50% and 90% points of the digital input and switch on condition.

t_{OFF} ($\overline{\text{EN}}$)

Delay time between the 50% and 90% points of the digital input and switch off condition.

t_{TRANSITION}

Delay time between the 50% and 90% points of the digital inputs and the switch on condition when switching from one address state to another.

t_{BBM}

Off time measured between the 80% point of both switches when switching from one address state to another.

V_{INL}

Maximum input voltage for Logic 0.

V_{INH}

Minimum input voltage for Logic 1.

I_{INL}, I_{INH}

Input current of the digital input.

I_{DD}

Positive supply current.

I_{SS}

Negative supply current.

Off Isolation

A measure of an unwanted signal coupling through an off channel.

Charge Injection

A measure of the glitch impulse transferred from the digital input to the analog output during switching.

Bandwidth

Frequency at which the output is attenuated by 3 dB.

On Response

Frequency response of the on switch.

THD + N

Ratio of the harmonic amplitude plus noise of the signal to the fundamental.

TYPICAL PERFORMANCE CHARACTERISTICS

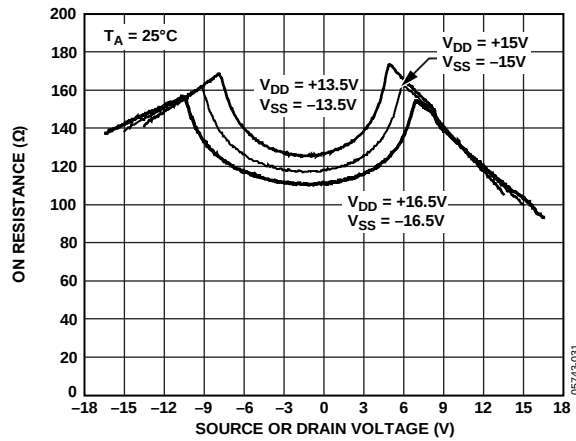
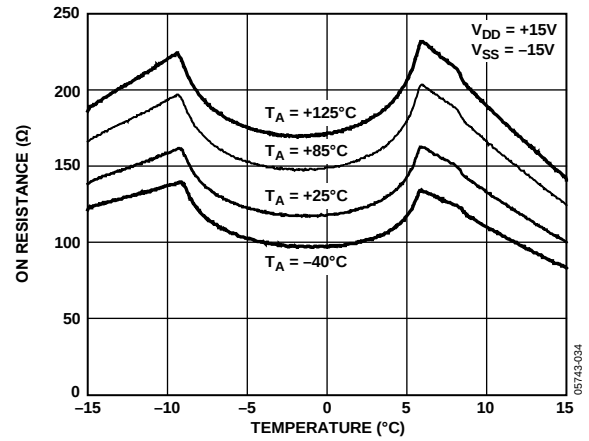
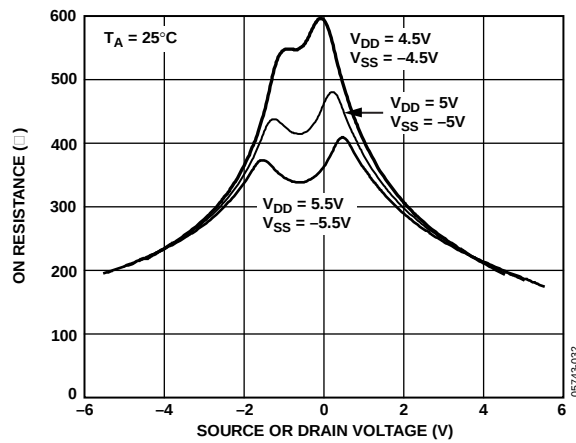
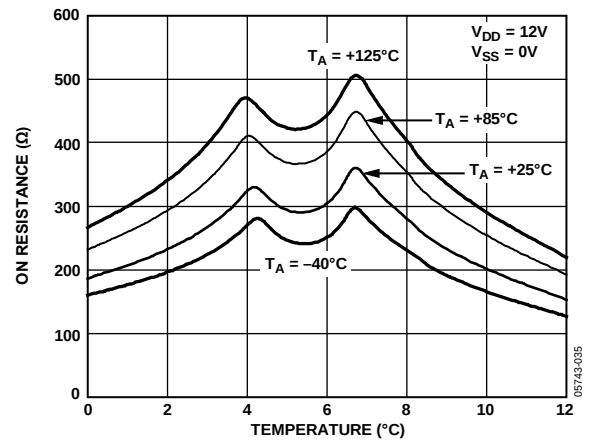
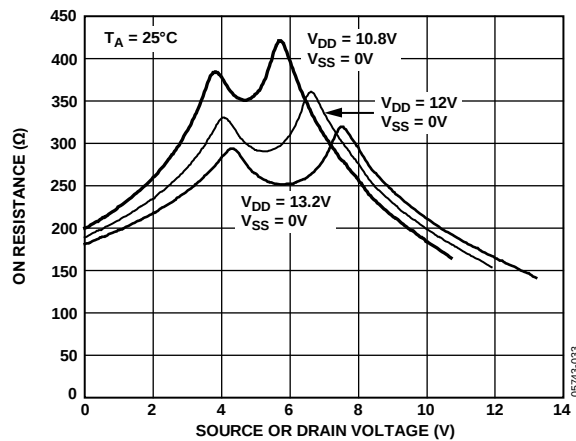
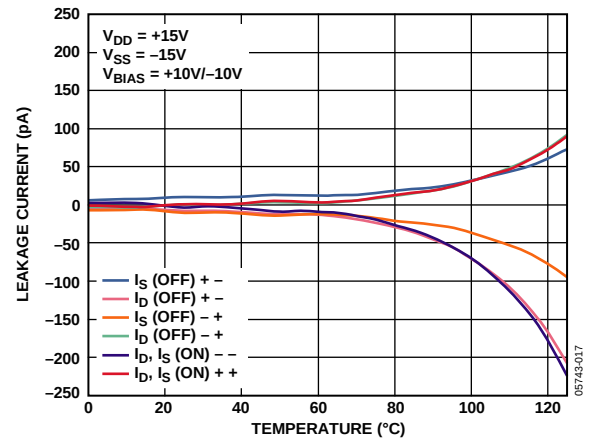
Figure 7. On Resistance as a Function of V_D (V_S) for Dual SupplyFigure 10. On Resistance as a Function of V_D (V_S) for Different Temperatures, Dual SupplyFigure 8. On Resistance as a Function of V_D (V_S) for Dual SupplyFigure 11. On Resistance as a Function of V_D (V_S) for Different Temperatures, Single SupplyFigure 9. On Resistance as a Function of V_D (V_S) for Single Supply

Figure 12. Leakage Currents as a Function of Temperature, Dual Supply

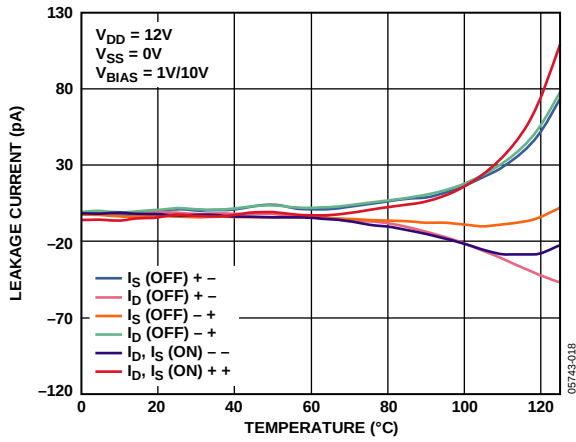


Figure 13. Leakage Currents as a Function of Temperature, Single Supply

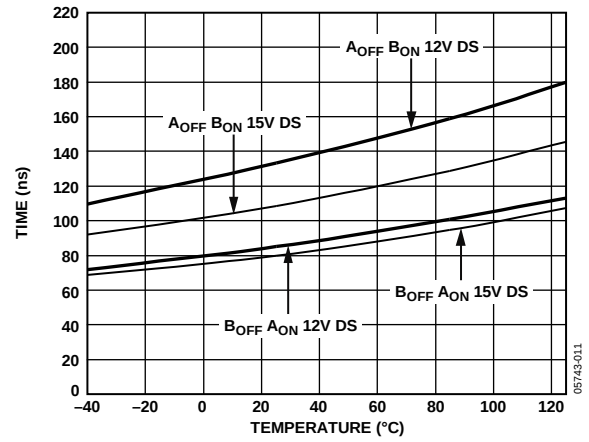


Figure 16. $t_{\text{TRANSITION}}$ vs. Temperature

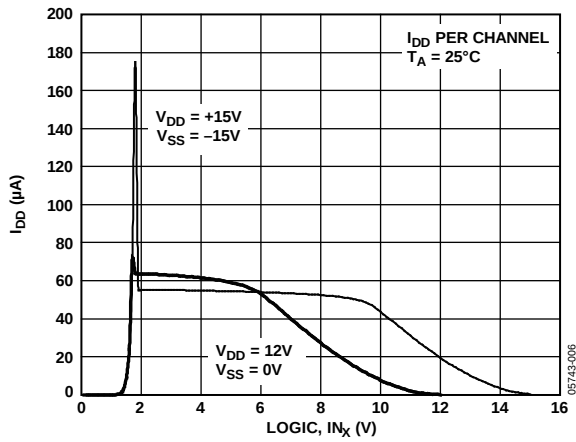


Figure 14. I_{DD} vs. Logic Level

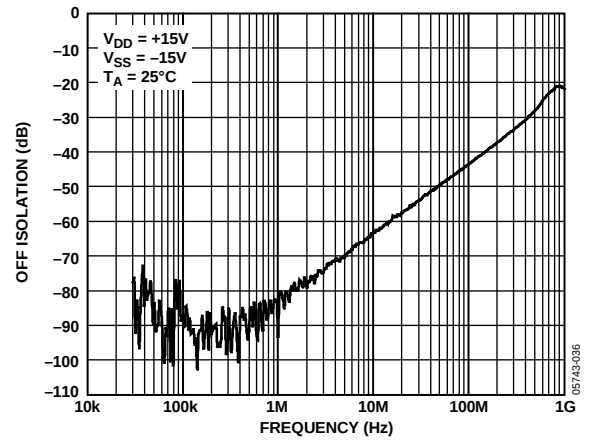


Figure 17. Off Isolation vs. Frequency

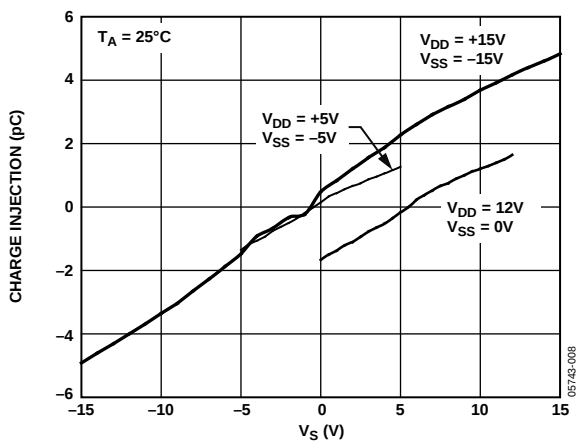


Figure 15. Charge Injection vs. Source Voltage

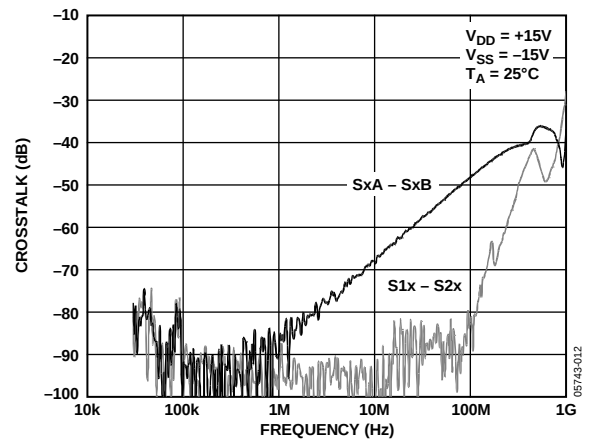


Figure 18. Crosstalk vs. Frequency

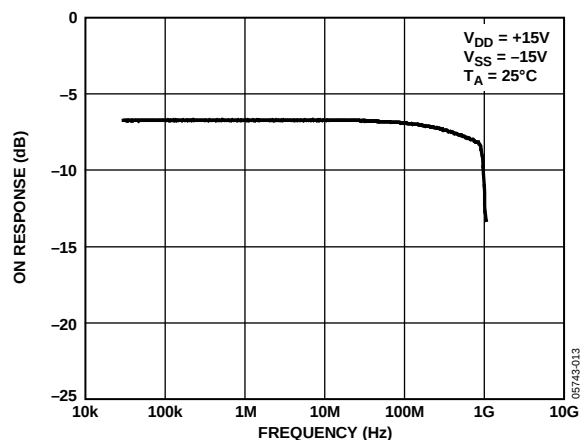


Figure 19. On Response vs. Frequency

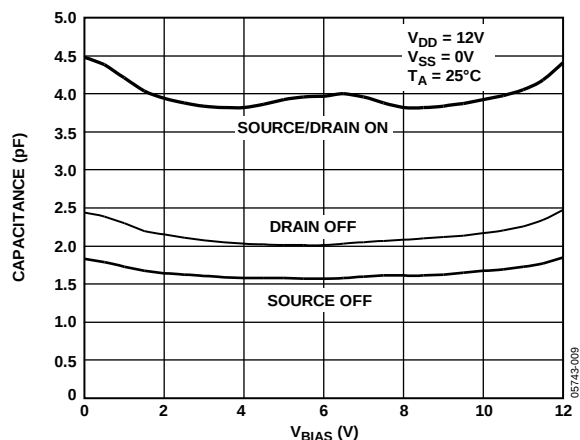


Figure 22. Capacitance vs. Source Voltage for Single Supply

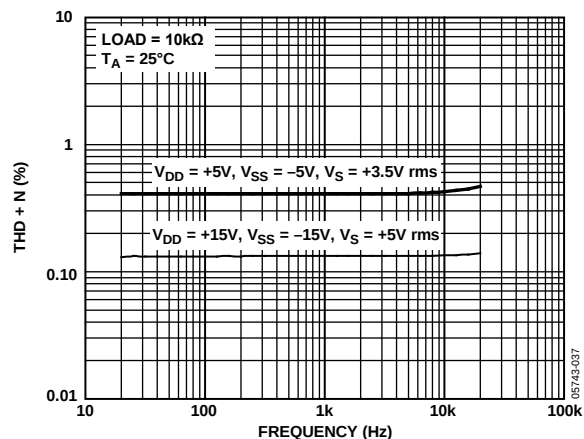


Figure 20. THD + N vs. Frequency

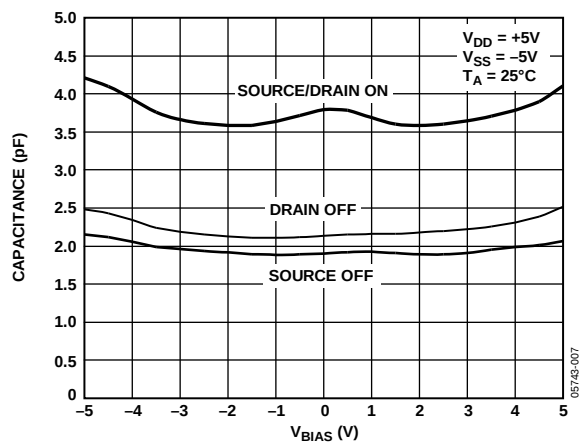


Figure 23. Capacitance vs. Source Voltage for Dual Supply

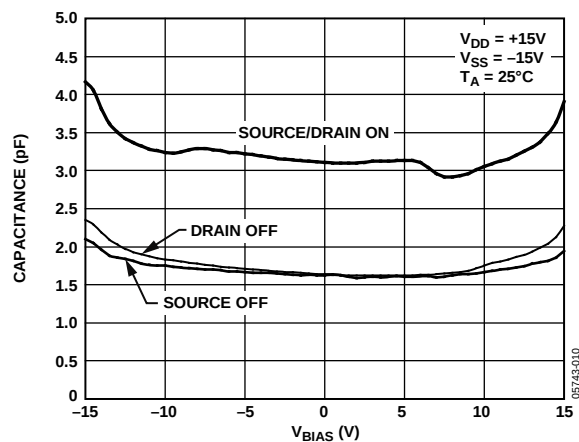


Figure 21. Capacitance vs. Source Voltage for Dual Supply

TEST CIRCUITS

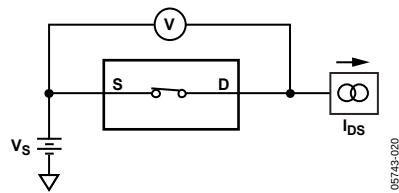


Figure 24. On Resistance

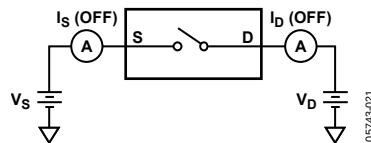


Figure 25. Off Leakage

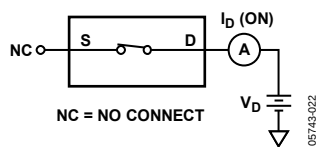


Figure 26. On Leakage

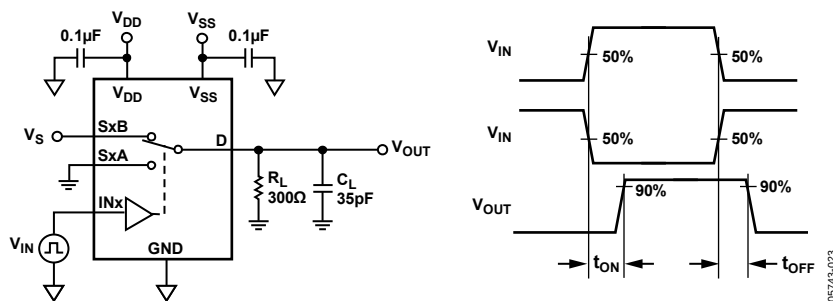


Figure 27. Switching Timing

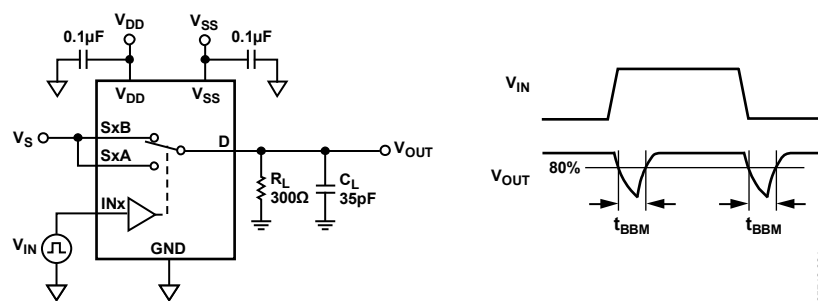


Figure 28. Break-Before-Make Delay

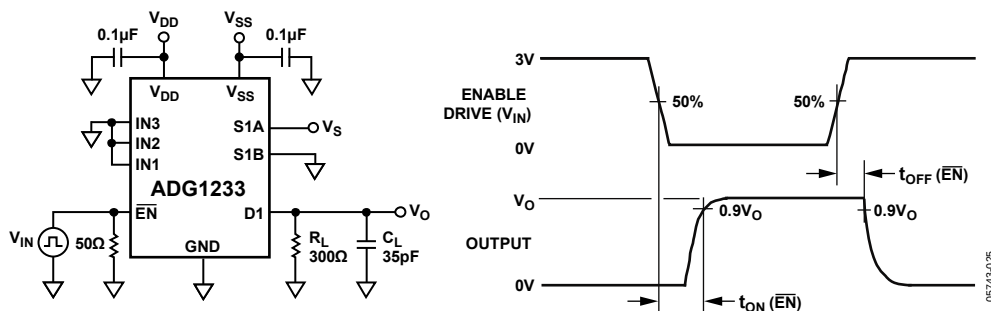
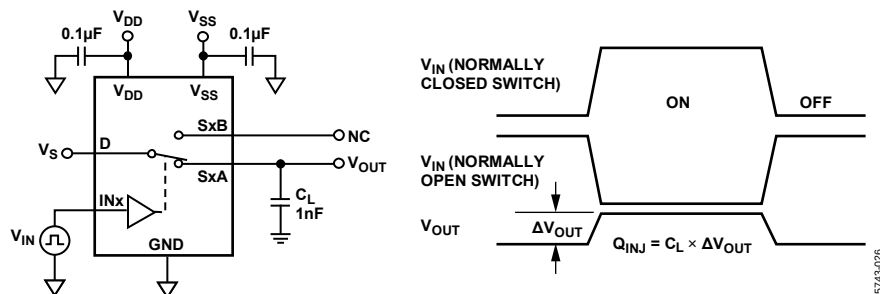
Figure 29. Enable Delay, $t_{ON}(\overline{EN})$, $t_{OFF}(\overline{EN})$ 

Figure 30. Charge Injection

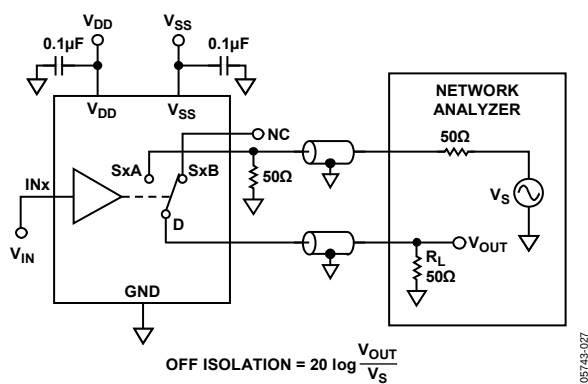


Figure 31. Off Isolation

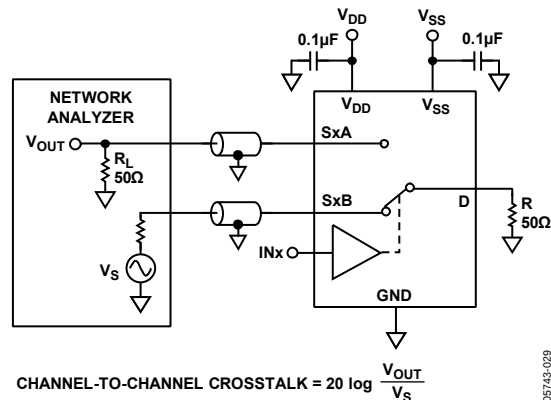


Figure 33. Channel-to-Channel Crosstalk

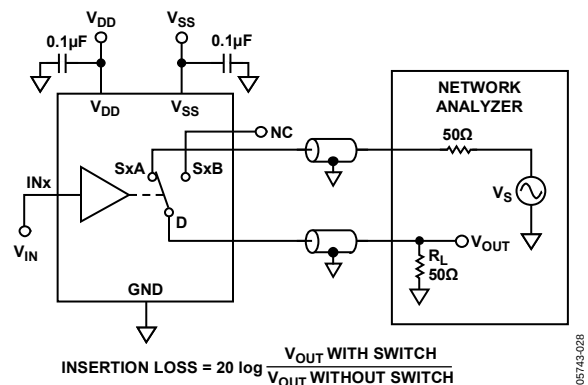


Figure 32. Bandwidth

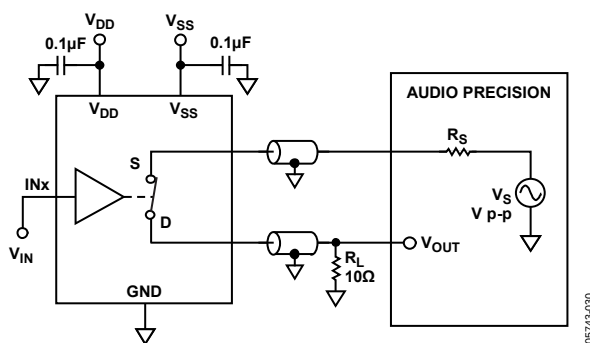
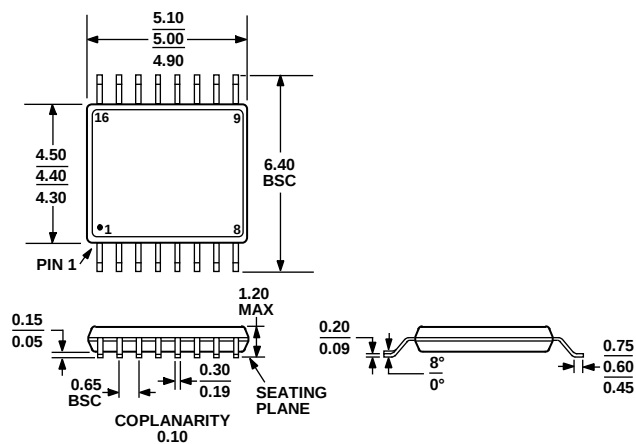


Figure 34. THD + Noise

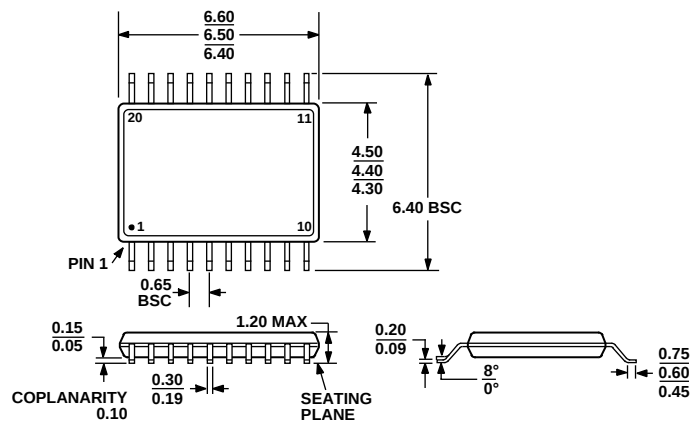
OUTLINE DIMENSIONS



COMPLIANT TO JEDEC STANDARDS MO-153-AB

Figure 35. 16-Lead Thin Shrink Small Outline Package [TSSOP]
(RU-16)

Dimensions shown in millimeters



COMPLIANT TO JEDEC STANDARDS MO-153-AC

Figure 36. 20-Lead Thin Shrink Small Outline Package [TSSOP]
(RU-20)

Dimensions shown in millimeters

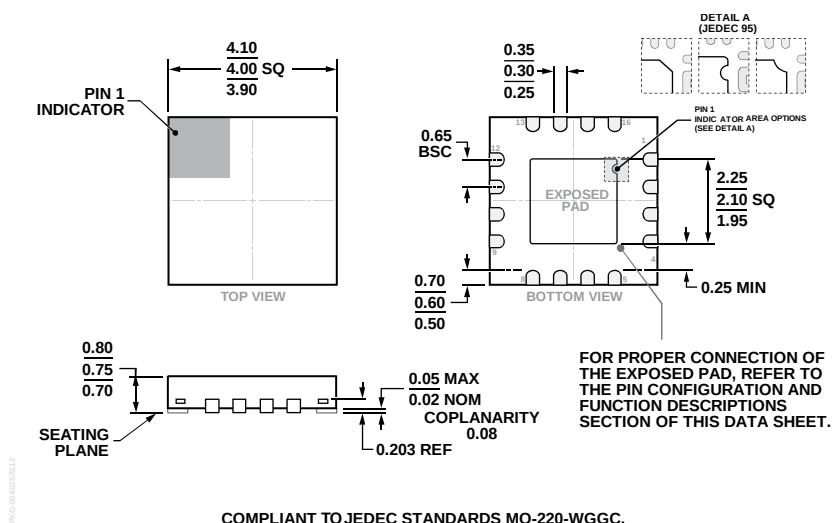


Figure 37. 16-Lead Lead Frame Chip Scale Package [LFCSP]
4 mm × 4 mm Body and 0.75 mm Package Height
(CP-16-23)

Dimensions shown in millimeters

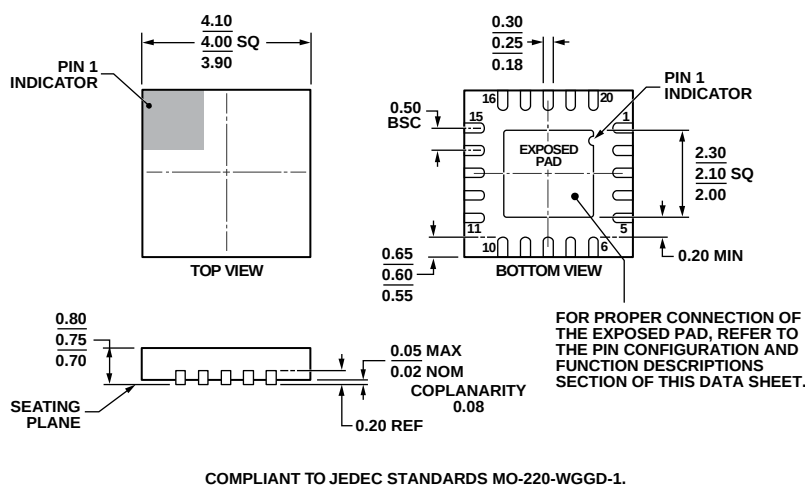


Figure 38. 20-Lead Lead Frame Chip Scale Package [LFCSP]
4 mm × 4 mm Body and 0.75 mm Package Height
(CP-20-6)

Dimensions shown in millimeters

ORDERING GUIDE

Model ¹	Temperature Range	Package Description	Package Option
ADG1233YRUZ	−40°C to +125°C	16-Lead Thin Shrink Small Outline Package [TSSOP]	RU-16
ADG1233YRUZ-REEL7	−40°C to +125°C	16-Lead Thin Shrink Small Outline Package [TSSOP]	RU-16
ADG1233YCPZ-REEL7	−40°C to +125°C	16-Lead Lead Frame Chip Scale Package [LFCSP]	CP-16-23
ADG1234YRUZ	−40°C to +125°C	20-Lead Thin Shrink Small Outline Package [TSSOP]	RU-20
ADG1234YRUZ-REEL7	−40°C to +125°C	20-Lead Thin Shrink Small Outline Package [TSSOP]	RU-20
ADG1234YCPZ-REEL	−40°C to +125°C	20-Lead Lead Frame Chip Scale Package [LFCSP]	CP-20-6
ADG1234YCPZ-REEL7	−40°C to +125°C	20-Lead Lead Frame Chip Scale Package [LFCSP]	CP-20-6

¹ Z = RoHS Compliant Part.